FETKYTM

P-Channel Enhancement-Mode **Power MOSFET and Schottky Diode Dual SO-8 Package**

Features

- High Efficiency Components in a Single SO-8 Package
- High Density Power MOSFET with Low R_{DS(on)}, Schottky Diode with Low V_F
- Independent Pin-Outs for MOSFET and Schottky Die Allowing for Flexibility in Application Use
- Less Component Placement for Board Space Savings
- SO-8 Surface Mount Package, Mounting Information for SO-8 Package Provided
- Pb-Free Packages are Available

Applications

- DC-DC Converters
- Low Voltage Motor Control
- Power Management in Portable and Battery-Powered Products, i.e.: Computers, Printers, PCMCIA Cards, Cellular and Cordless Telephones

MOSFET MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise noted).

Rating	Symbol	Value	Unit
Drain-to-Source Voltage	V _{DSS}	-20	V
Gate-to-Source Voltage - Continuous	V_{GS}	±20	V
Thermal Resistance – Junction-to-Ambient (Note 1) Total Power Dissipation @ T _A = 25°C Continuous Drain Current @ T _A = 25°C Continuous Drain Current @ T _A = 70°C Pulsed Drain Current (Note 4)	R _{0JA} P _D I _D I _{DM}	171 0.73 -2.34 -1.87 -8.0	°C/W W A A
Thermal Resistance – Junction-to-Ambient (Note 2) Total Power Dissipation @ T _A = 25°C Continuous Drain Current @ T _A = 25°C Continuous Drain Current @ T _A = 70°C Pulsed Drain Current (Note 4)	R _{0JA} P _D I _D I _{DM}	100 1.25 -3.05 -2.44 -12	°C/W W A A
Thermal Resistance – Junction-to-Ambient (Note 3) Total Power Dissipation @ T _A = 25°C Continuous Drain Current @ T _A = 25°C Continuous Drain Current @ T _A = 70°C Pulsed Drain Current (Note 4)	R _{0JA} P _D I _D I _D	62.5 2.0 -3.86 -3.10 -15	°C/W W A A
Operating and Storage Temperature Range	T _J , T _{stg}	-55 to +150	°C
Single Pulse Drain-to-Source Avalanche Energy - Starting T_J = 25°C (V_{DD} = -20 Vdc, V_{GS} = -4.5 Vdc, Peak I_L = -7.5 Apk, L = 5 mH, R_G = 25 Ω)	E _{AS}	140	mJ
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Minimum FR-4 or G-10 PCB, Steady State.
 Mounted onto a 2" square FR-4 Board (1 in sq, 2 oz Cu 0.06" thick single-sided), Steady State.
- Mounted onto a 2" square FR-4 Board (1 in sq, 2 oz Cu 0.06" thick single sided), $t \le 10$ seconds.
- 4. Pulse Test: Pulse Width = 300 μs, Duty Cycle = 2%.



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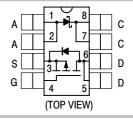
http://onsemi.com

MOSFET -3.05 AMPERES -20 VOLTS

0.085 Ω @ V_{GS} = -10 V

SCHOTTKY DIODE 1.0 AMPERE 20 VOLTS

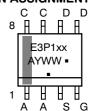
470 mV @ I_F = 1.0 A



MARKING DIAGRAM & PIN ASSIGNMENT



CASE 751 STYLE 18



E3P1 = Device Code = 02 or S XX

= Assembly Location Α

= Year WW = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMSD3P102R2	SO-8	2500/Tape & Reel
NTMSD3P102R2G	SO-8 (Pb-Free)	2500/Tape & Reel
NTMSD3P102R2SG	SO-8 (Pb-Free)	2500/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

SCHOTTKY MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Peak Repetitive Reverse Voltage DC Blocking Voltage	V _{RRM} V _R	20	V
Thermal Resistance - Junction-to-Ambient (Note 5)	$R_{ heta JA}$	204	°C/W
Thermal Resistance - Junction-to-Ambient (Note 6)	$R_{ heta JA}$	122	°C/W
Thermal Resistance - Junction-to-Ambient (Note 7)	$R_{ heta JA}$	83	°C/W
Average Forward Current (Note 7) (Rated V _R , T _A = 100°C)	I _O	1.0	А
Peak Repetitive Forward Current (Note 7) (Rated V _R , Square Wave, 20 kHz, T _A = 105°C)	I _{FRM}	2.0	А
Non-Repetitive Peak Surge Current (Note 7) (Surge Applied at Rated Load Conditions, Half-Wave, Single Phase, 60 Hz)	IFSM	20	А

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- Minimum FR-4 or G-10 PCB, Steady State.
 Mounted onto a 2" square FR-4 Board (1 in sq, 2 oz Cu 0.06" thick single-sided), Steady State.
 Mounted onto a 2" square FR-4 Board (1 in sq, 2 oz Cu 0.06" thick single sided), t ≤ 10 seconds.

SCHOTTKY ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (Note 8)

Characteristic		Symbol	Value		Unit
Maximum Instantaneous Forward Voltage	I _F = 1.0 Adc I _F = 2.0 Adc	V _F	T _J = 25°C	T _J = 125°C	Volts
Maximum Instantaneous Forward Voltage	I _F = 1.0 Adc I _F = 2.0 Adc	V _F	0.47 0.58	0.39 0.53	Volts
Maximum Instantaneous Reverse Current		I _R	T _J = 25°C	T _J = 125°C	mA
	V _R = 20 Vdc		0.05	10	
Maximum Voltage Rate of Change	V _R = 20 Vdc	dV/dt	10,000		V/μs

^{8.} Indicates Pulse Test: Pulse Width = 300 μ s max, Duty Cycle = 2%.

MOSFET ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted) (Note 9)

Characteristic			Min	Тур	Max	Unit
OFF CHARACTERISTICS		•			•	•
Drain-to-Source Breakdown Volta ($V_{GS} = 0$ Vdc, $I_D = -250 \mu Adc$) Temperature Coefficient (Positive)	ge	V _{(BR)DSS}	-20 -	- -30	- -	Vdc mV/°C
Zero Gate Voltage Drain Current $(V_{DS} = -20 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T $ $(V_{DS} = -20 \text{ Vdc}, V_{GS} = 0 \text{ Vdc}, T $		I _{DSS}		- -	-1.0 -25	μAdc
Gate-Body Leakage Current (V _{GS} = -20 Vdc, V _{DS} = 0 Vdc)		I _{GSS}	-	-	-100	nAdc
Gate-Body Leakage Current (V _{GS} = +20 Vdc, V _{DS} = 0 Vdc)		I _{GSS}	-	_	100	nAdc
ON CHARACTERISTICS				1	!	Į.
Gate Threshold Voltage (V _{DS} = V _{GS} , I _D = -250 μAdc) Temperature Coefficient (Negative)		V _{GS(th)}	-1.0 -	-1.7 3.6	-2.5 -	Vdc
Static Drain-to-Source On-State Resistance $(V_{GS} = -10 \text{ Vdc}, I_D = -3.05 \text{ Adc})$ $(V_{GS} = -4.5 \text{ Vdc}, I_D = -1.5 \text{ Adc})$			- -	0.063 0.090	0.085 0.125	Ω
Forward Transconductance (V _{DS} = -15 Vdc, I _D = -3.05 Adc)			-	5.0	-	Mhos
OYNAMIC CHARACTERISTICS						
Input Capacitance		C _{iss}	-	518	750	pF
Output Capacitance	$(V_{DS} = -16 \text{ Vdc}, V_{GS} = 0 \text{ Vdc},$ f = 1.0 MHz)	C _{oss}	-	190	350	
Reverse Transfer Capacitance		C _{rss}	-	70	135	
SWITCHING CHARACTERISTICS (Notes 10 & 11)					
Turn-On Delay Time		t _{d(on)}	-	12	22	ns
Rise Time	$(V_{DD} = -20 \text{ Vdc}, I_D = -3.05 \text{ Adc},$	t _r	-	16	30	
Turn-Off Delay Time	V_{GS} = -10 Vdc, R_{G} = 6.0 Ω)	t _{d(off)}	-	45	80	
Fall Time		t _f	-	45	80	
Turn-On Delay Time		t _{d(on)}	-	16	-	ns
Rise Time	$(V_{DD} = -20 \text{ Vdc}, I_D = -1.5 \text{ Adc},$	t _r	-	42	-]
Turn-Off Delay Time	V_{GS} = -4.5 Vdc, R_G = 6.0 Ω)	t _{d(off)}	-	32	-	
Fall Time		t _f	-	35	_	
Total Gate Charge	0/ 20 \/do	Q _{tot}	-	16	25	nC
Gate-Source Charge	$V_{DS} = -20 \text{ Vdc},$ $V_{GS} = -10 \text{ Vdc},$	Q _{gs}	-	2.0	-	1
Gate-Drain Charge	$I_D = -3.05 \text{ Adc}$	Q _{gd}	-	4.5	-	1
BODY-DRAIN DIODE RATINGS (N	ote 10)			•	•	•
Diode Forward On-Voltage	$(I_S = -3.05 \text{ Adc}, V_{GS} = 0 \text{ Vdc})$ $(I_S = -3.05 \text{ Adc}, V_{GS} = 0 \text{ Vdc}, T_J = 125^{\circ}\text{C})$	V _{SD}	-	-0.96 -0.78	-1.25 -	Vdc
Reverse Recovery Time		t _{rr}	-	34	-	ns
	$(I_S = -3.05 \text{ Adc}, V_{GS} = 0 \text{ Vdc},$ $dI_S/dt = 100 \text{ A}/\mu\text{s})$	t _a	-	18	-	1
	αισιαι – 100 Αγμο)	t _b	-	16	-	1
Reverse Recovery Stored Charge			-	0.03	_	μС

^{9.} Handling precautions to protect against electrostatic discharge are mandatory. 10. Indicates Pulse Test: Pulse Width = 300 μ s max, Duty Cycle = 2%. 11. Switching characteristics are independent of operating junction temperature.

TYPICAL MOSFET ELECTRICAL CHARACTERISTICS

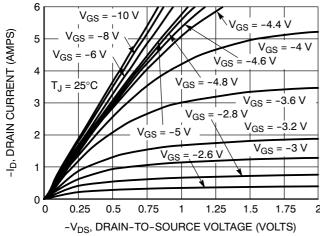


Figure 1. On-Region Characteristics

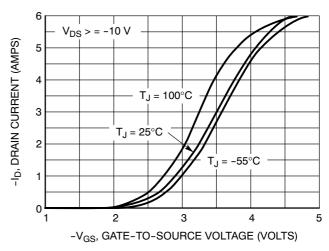


Figure 2. Transfer Characteristics

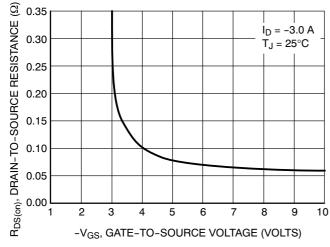


Figure 3. On-Resistance vs. Gate-to-Source Voltage

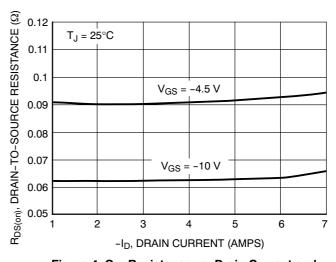


Figure 4. On-Resistance vs. Drain Current and Gate Voltage

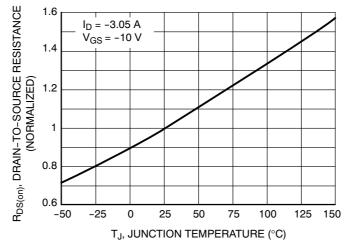


Figure 5. On Resistance Variation with Temperature

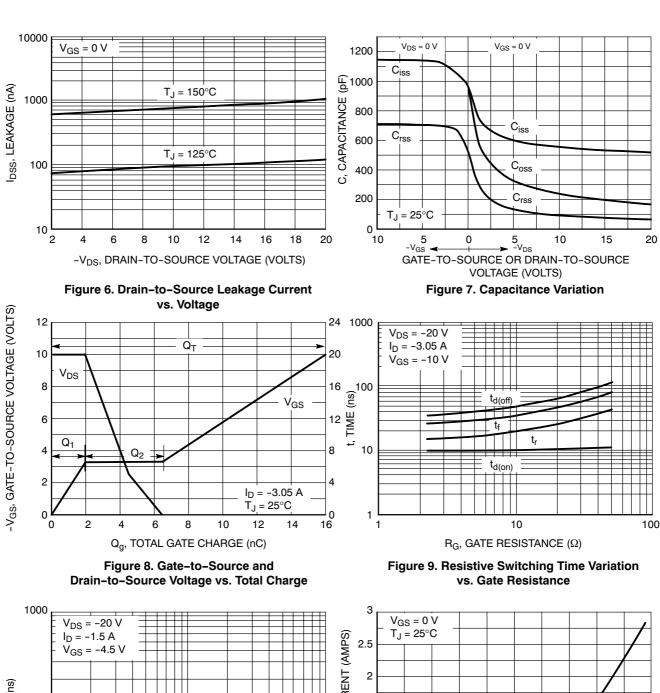


Figure 10. Resistive Switching Time Variation vs. Gate Resistance

Figure 11. Diode Forward Voltage vs. Current

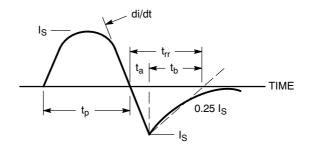


Figure 12. Diode Reverse Recovery Waveform

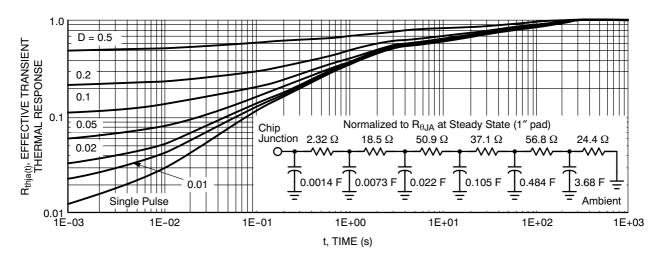


Figure 13. FET Thermal Response

TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS

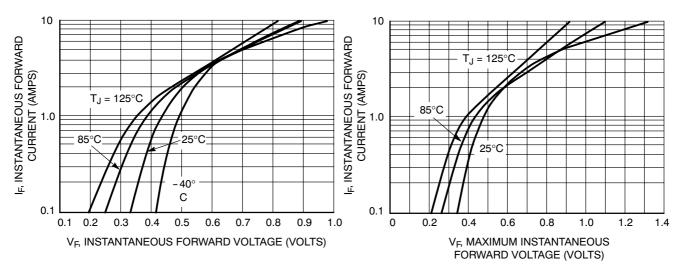


Figure 14. Typical Forward Voltage

Figure 15. Maximum Forward Voltage

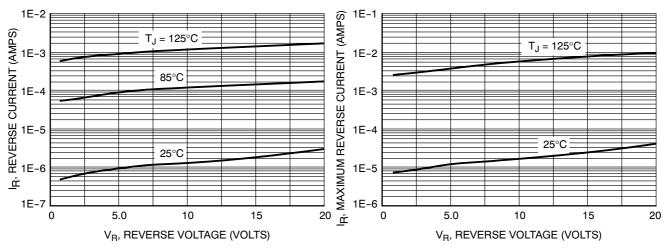


Figure 16. Typical Reverse Current

Figure 17. Maximum Reverse Current

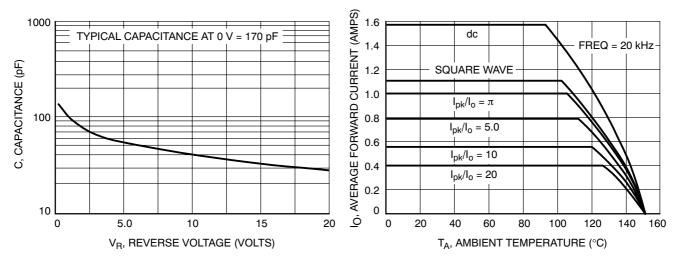


Figure 18. Typical Capacitance

Figure 19. Current Derating

TYPICAL SCHOTTKY ELECTRICAL CHARACTERISTICS

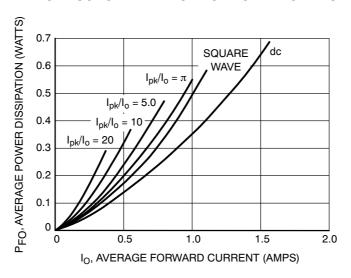


Figure 20. Forward Power Dissipation

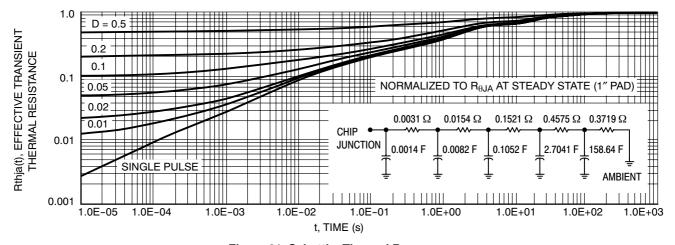
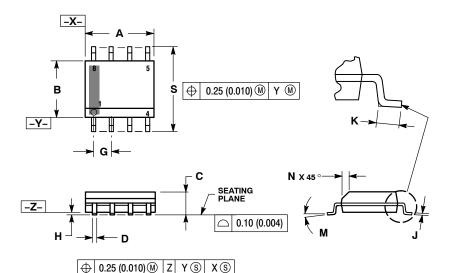


Figure 21. Schottky Thermal Response



SOIC-8 NB CASE 751-07 **ISSUE AK**

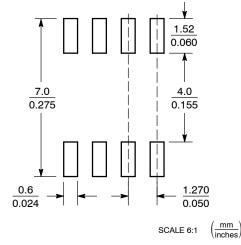
DATE 16 FEB 2011



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

	MILLIMETERS		INC	HES
DIM	MIN	MAX	MIN	MAX
Α	4.80	5.00	0.189	0.197
В	3.80	4.00	0.150	0.157
C	1.35	1.75	0.053	0.069
D	0.33	0.51	0.013	0.020
G	1.27 BSC		0.050 BSC	
Н	0.10	0.25	0.004	0.010
7	0.19	0.25	0.007	0.010
K	0.40	1.27	0.016	0.050
M	0 °	8 °	0 °	8 °
N	0.25	0.50	0.010	0.020
S	5.80	6.20	0.228	0.244

SOLDERING FOOTPRINT*



^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

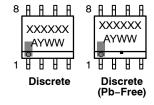
GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location = Wafer Lot

= Year = Work Week

= Pb-Free Package



XXXXXX = Specific Device Code = Assembly Location Α

= Year ww

= Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb–Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

STYLES ON PAGE 2

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SOIC-8 NB CASE 751-07 ISSUE AK

DATE 16 FEB 2011

STYLE 3: PIN 1. DRAIN, PIE #1 CTOR, #1 CTOR, #2 CTOR, #1 CTOR, #2 CTOR, #2 CTOR, #2 CTOR, #2 CTOR, #1	2. ANODE 3. ANODE 4. ANODE 5. ANODE 6. ANODE 7. ANODE 8. COMMON CATHODE STYLE 8: PIN 1. COLLECTOR, DIE #1 2. BASE, #1 3. BASE, #2 4. COLLECTOR, #2 5. COLLECTOR, #2 6. EMITTER, #1 Vd STYLE 12: PIN 1. SOURCE 2. SOURCE 3. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN 8. TYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #1
E PIN 1. INPUT 2. EXTERNAL BY 3. THIRD STAGE 4. GROUND E 5. DRAIN 6. GATE 3 7. SECOND STAGE 8. FIRST STAGE STYLE 11: ID PIN 1. SOURCE 1 2. GATE 1 T 3. SOURCE 2 ID 4. GATE 2 ID 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 ID 8. DRAIN 1 ID	PIN 1. COLLECTOR, DIE #1 2. BASE, #1 3. BASE, #2 4. COLLECTOR, #2 5. COLLECTOR, #2 6. EMITTER, #2 7. EMITTER, #1 Vd 8. COLLECTOR, #1 STYLE 12: PIN 1. SOURCE 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN 8. TYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2
ID PIN 1. SOURCE 1 2. GATE 1 T 3. SOURCE 2 ID 4. GATE 2 ID 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 ID 8. DRAIN 1 STYLE 15: RCE PIN 1. ANODE 1 E 2. ANODE 1 RCE 3. ANODE 1	PIN 1. SOURCE 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN STYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2
STYLE 15: RCE PIN 1. ANODE 1 E 2. ANODE 1 RCE 3. ANODE 1	PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2
N 7. CATHODE, CON N 8. CATHODE, CON	MMON 5. COLLECTOR, DIE #2 MMON 6. COLLECTOR, DIE #2 MMON 7. COLLECTOR, DIE #1 MMON 8. COLLECTOR, DIE #1
STYLE 19: PIN 1. SOURCE 1 E 2. GATE 1 E 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. MIRROR 2 DE 7. DRAIN 1 DE 8. MIRROR 1	STYLE 20: PIN 1. SOURCE (N) 2. GATE (N) 3. SOURCE (P) 4. GATE (P) 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
STYLE 23: E1 PIN 1. LINE 1 IN DN CATHODE/VCC 2. COMMON ANC DN CATHODE/VCC 3. COMMON ANC E3 4. LINE 2 IN DN ANODE/GND 5. LINE 2 OUT E4 6. COMMON ANC E5 7. COMMON ANC DN ANODE/GND 8. LINE 1 OUT	ODE/GND 2. EMITTER ODE/GND 3. COLLECTOR/ANODE
STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ 5. SOURCE 6. SOURCE 6. SOURCE 7. SOURCE 8. DRAIN	STYLE 28: PIN 1. SW_TO_GND 2. DASIC_OFF 3. DASIC_SW_DET 4. GND 5. V MON 6. VBULK 7. VBULK 8. VIN
1 1	
;	STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ E 5. SOURCE E 6. SOURCE E 7. SOURCE 8. DRAIN

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